

Search Notes

Application/Control No.

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Examiner

Soon D. Hyun

Applicant(s)/Patent under
Reexamination

VIJAYAN ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
370/203- 208,210,503,506,507,516,520;375/35 4,355,362,367,371,373,375;text- printout	11/28/2007	HY